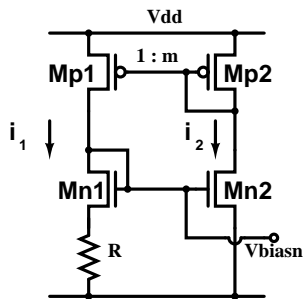


The Beta Multiplier



Therefore,

$$Rl_1 = \sqrt{\frac{2l_1}{K_{n1}}} \left(\sqrt{\frac{mK_{n1}}{K_{n2}}} - 1 \right)$$

We have $l_2 = ml_1$ with $m = \frac{(W/L)_{p2}}{(W/L)_{p1}}$

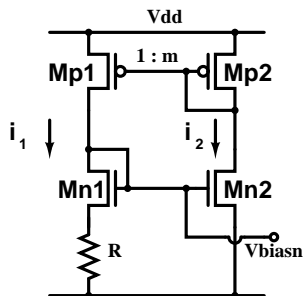
Equating voltages at the gates of n transistors:

$$V_{GS1} + Rl_1 = V_{GS2}$$

$$V_{Tn} + \sqrt{\frac{2l_1}{K_{n1}}} + Rl_1 = V_{Tn} + \sqrt{\frac{2l_2}{K_{n2}}}$$

$$\text{so } \sqrt{\frac{2l_1}{K_{n1}}} + Rl_1 = \sqrt{\frac{2ml_1}{K_{n2}}}$$

The Beta Multiplier



$$g_{mn1} = \frac{2}{R} \left(\sqrt{\frac{(W/L)_{p2}/(W/L)_{p1}}{(W/L)_{n2}/(W/L)_{n1}}} - 1 \right)$$

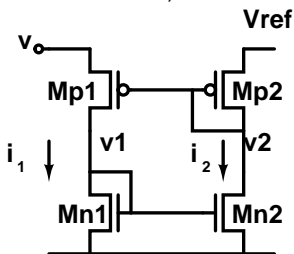
Thus g_{mn1} depends only on R and geometry.

Also, *any* nMOS transistor on the same chip whose current is proportional to I_1 or I_2 will have a g_{mn} which is unaffected by temperature, supply variation etc.

Thus the gate voltage of the n channel transistors (V_{biasn}) can be used to bias n channel transistors on the chip, whose g_m is to be kept constant.

Zero input impedance circuit

Low r_{in} amps are used for photo-detectors. (C.-K. Kim et al, "High Injection Efficiency Readout Circuit for Low Resistance Infrared Detector", IEE Electronic Letters, 35, 1507, 1999).



$$\begin{aligned}i_1 &= g_{mn1} v_1 = g_{mp1} (v - v_2) \\i_2 &= g_{mn2} v_1 = -g_{mp2} v_2 \\v_2 &= -\frac{g_{mn2}}{g_{mp2}} v_1 = -\frac{g_{mn2}}{g_{mp2}} \frac{i_1}{g_{mn1}}\end{aligned}$$

$$i_1 = g_{mp1} v + \frac{g_{mn2}/g_{mn1}}{g_{mp2}/g_{mp1}} i_1$$

$$\text{define } \Gamma \equiv \frac{g_{mn2}/g_{mn1}}{g_{mp2}/g_{mp1}}$$

$$\text{then, } i_1 (1 - \Gamma) = g_{mp1} v$$

This gives $r_{in} = (1 - \Gamma)/g_{mp1}$

By making $\Gamma = 1$, we can make $r_{in} = 0$.

Robustness of design

In saturation,

$$I_d = \frac{1}{2} \mu C_{ox} \frac{W}{L} (V_g - V_T)^2$$

$$\text{So, } g_m = \mu C_{ox} \frac{W}{L} (V_g - V_T) = \sqrt{2 \mu C_{ox} \frac{W}{L} I_d}$$

$$g_{mn2}/g_{mn1} = \sqrt{\frac{(W/L)_{n2} l_2}{(W/L)_{n1} l_1}}$$

$$g_{mp2}/g_{mp1} = \sqrt{\frac{(W/L)_{p2} l_2}{(W/L)_{p1} l_1}}$$

$$\text{Therefore } \Gamma \equiv \frac{g_{mn2}/g_{mn1}}{g_{mp2}/g_{mp1}} = \sqrt{\frac{(W/L)_{n2}/(W/L)_{n1}}{(W/L)_{p2}/(W/L)_{p1}}}$$

Thus Γ depends only on geometry and is independent of temperature and device parameter variation.